

MOSFET

Metal Oxide Semiconductor Field Effect Transistor

CoolMOS™ C7

650V CoolMOS™ C7 Power Transistor IPP65R065C7

Data Sheet

Rev. 2.0 Final



IPP65R065C7

1 Description

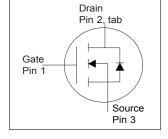
CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies.

CoolMOS™ C7 series combines the experience of the leading SJ MOSFET supplier with high class innovation. The product portfolio provides all benefits of fast switching superjunction MOSFETs offering better efficiency, reduced gate charge, easy implementation and outstanding reliability.

TO-220 tab

Features

- Increased MOSFET dv/dt ruggedness
- Better efficiency due to best in class FOM R_{DS(on)}*E_{oss} and R_{DS(on)}*Q_g
- Best in class R_{DS(on)} /package
- · Easy to use/drive
- Pb-free plating, halogen free mold compound
- Qualified for industrial grade applications according to JEDEC (J-STD20 and JESD22)



Benefits

- · Enabling higher system efficiency
- Enabling higher frequency / increased power density solutions
- System cost / size savings due to reduced cooling requirements
- Higher system reliability due to lower operating temperatures





Applications

PFC stages and hard switching PWM stages for e.g. Computing, Server, Telecom, UPS and Solar.

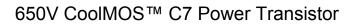
Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.



Table 1 Key Performance Parameters

Table 1 110y 1 of formation 1 aramotore							
Parameter	Value	Unit					
V _{DS} @ T _{j,max}	700	V					
R _{DS(on),max}	65	mΩ					
Q _{g.typ}	64	nC					
I _{D,pulse}	145	A					
E _{oss} @400V	8	μJ					
Body diode di/dt	60	A/µs					

Type / Ordering Code	Package	Marking	Related Links
IPP65R065C7	PG-TO 220	65C7065	see Appendix A





IPP65R065C7

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2 Maximum ratings at $T_j = 25$ °C, unless otherwise specified

Table 2 Maximum ratings

Davamatav	Cumbal		Values			Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current 1)	I_{D}	-	-	33 21	А	T _C =25°C T _C =100°C
Pulsed drain current 2)	I _{D,pulse}	-	-	145	Α	T _C =25°C
Avalanche energy, single pulse	E AS	-	-	171	mJ	I _D =10.2A; V _{DD} =50V; see table 10
Avalanche energy, repetitive	E AR	-	-	0.85	mJ	I _D =10.2A; V _{DD} =50V; see table 10
Avalanche current, single pulse	I _{AS}	-	-	10.2	Α	-
MOSFET dv/dt ruggedness	dv/dt	-	-	100	V/ns	V _{DS} =0400V
Gate source voltage (static)	V _{GS}	-20	-	20	V	static;
Gate source voltage (dynamic)	V _{GS}	-30	-	30	V	AC (f>1 Hz)
Power dissipation	P _{tot}	-	-	171	W	<i>T</i> _C =25°C
Storage temperature	$T_{ m stg}$	-55	-	150	°C	-
Operating junction temperature	T _j	-55	-	150	°C	-
Mounting torque	-	-	-	60	Ncm	M3 and M3.5 screws
Continuous diode forward current	I _S	-	-	33	Α	<i>T</i> _C =25°C
Diode pulse current ²⁾	I _{S,pulse}	-	-	145	Α	T _C =25°C
Reverse diode dv/dt ³⁾	dv/dt	-	-	1.5	V/ns	$V_{\rm DS}$ =0400V, $I_{\rm SD}$ <= $I_{\rm S}$, $T_{\rm j}$ =25°C see table 8
Maximum diode commutation speed	di _f /dt	-	-	60	A/μs	$V_{\rm DS}$ =0400V, $I_{\rm SD}$ <= $I_{\rm S}$, $T_{\rm j}$ =25°C see table 8
Insulation withstand voltage	V _{ISO}	-	_	n.a.	V	V _{rms} , T _C =25°C, t=1min

 $^{^{1)}}$ Limited by $T_{j\,max}.$ $^{2)}$ Pulse width t_p limited by $T_{j,max}$ $^{3)}$ Identical low side and high side switch with identical $\textit{R}_{\textrm{G}}$



3 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			11	Nata / Taat Candition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R _{thJC}	-	-	0.73	°C/W	-
Thermal resistance, junction - ambient	R _{thJA}	-	-	62	°C/W	leaded
Thermal resistance, junction - ambient for SMD version	R _{thJA}	-	-	-	°C/W	n.a.
Soldering temperature, wavesoldering only allowed at leads	T _{sold}	-	-	260	°C	1.6mm (0.063 in.) from case for 10s



4 Electrical characteristics at T_j =25°C, unless otherwise specified

Table 4 **Static characteristics**

Parameter	Comple of		Values			
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	650	-	-	V	V_{GS} =0V, I_D =1mA
Gate threshold voltage	V _{(GS)th}	3	3.5	4	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=0.85{\rm mA}$
Zero gate voltage drain current	I _{DSS}	-	- 15	1 -	μΑ	V _{DS} =650, V _{GS} =0V, T _j =25°C V _{DS} =650, V _{GS} =0V, T _j =150°C
Gate-source leakage current	I _{GSS}	-	-	100	nA	V _{GS} =20V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	0.058 0.138	0.065	Ω	V _{GS} =10V, I _D =17.1A, T _j =25°C V _{GS} =10V, I _D =17.1A, T _j =150°C
Gate resistance	R _G	-	0.85	-	Ω	f=1MHz, open drain

Table 5 **Dynamic characteristics**

Davamatav	Cumbal	Values			11:4	Note / Took Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	3020	-	pF	V _{GS} =0V, V _{DS} =400V, f=250kHz
Output capacitance	Coss	-	48	-	pF	V _{GS} =0V, V _{DS} =400V, f=250kHz
Effective output capacitance, energy related 1)	C _{o(er)}	-	100	-	pF	V _{GS} =0V, V _{DS} =0400V
Effective output capacitance, time related	C _{o(tr)}	-	1110	-	pF	I_D =constant, V_{GS} =0V, V_{DS} =0400V
Turn-on delay time	t _{d(on)}	-	17	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 Ω ; see table 9
Rise time	t _r	-	14	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 Ω ; see table 9
Turn-off delay time	$t_{ m d(off)}$	-	72	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 Ω ; see table 9
Fall time	t _f	-	7	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13 V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 Ω ; see table 9

Table 6 Gate charge characteristics

Parameter	O. wala a l		Values			Nata / Tank Oan differen
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	16	-	nC	$V_{\rm DD}$ =400V, $I_{\rm D}$ =17.1A, $V_{\rm GS}$ =0 to 10V
Gate to drain charge	$Q_{ m gd}$	-	21	-	nC	$V_{\rm DD}$ =400V, $I_{\rm D}$ =17.1A, $V_{\rm GS}$ =0 to 10V
Gate charge total	Qg	-	64	-	nC	$V_{\rm DD}$ =400V, $I_{\rm D}$ =17.1A, $V_{\rm GS}$ =0 to 10V
Gate plateau voltage	V _{plateau}	-	5.4	-	V	$V_{\rm DD}$ =400V, $I_{\rm D}$ =17.1A, $V_{\rm GS}$ =0 to 10V

 $^{^{1)}}$ $C_{\text{o(er)}}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 400V $^{2)}$ $C_{\text{o(tr)}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 400V



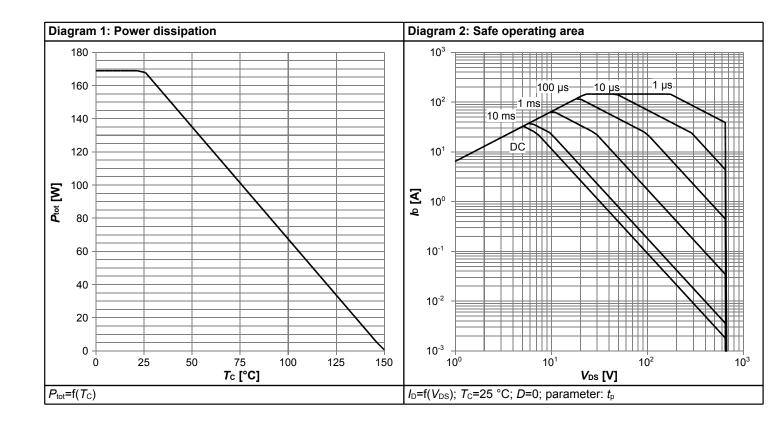
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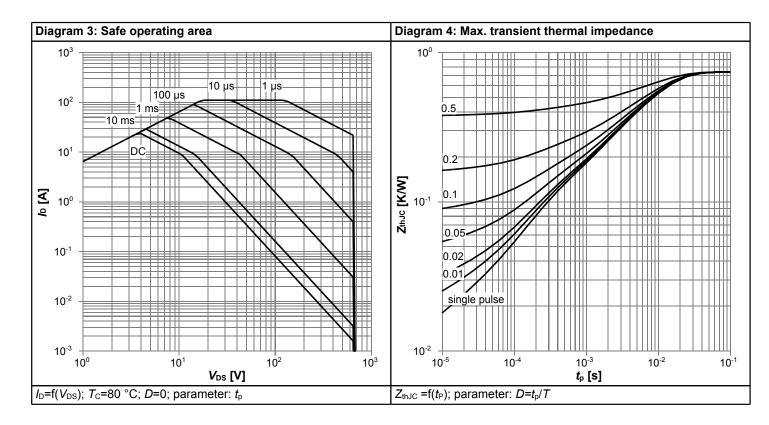
Table 7 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
Parameter		Min.	Тур.	Max.	Oilit	Note / Test Condition
Diode forward voltage	V _{SD}	-	0.9	-	V	V_{GS} =0V, I_F =17.1A, T_j =25°C
Reverse recovery time	t _{rr}	-	800	-	ns	V_R =400V, I_F =33A, di_F/dt =60A/ μ s; see table 8
Reverse recovery charge	Q _{rr}	-	10	-	μC	V_R =400V, I_F =33A, di_F/dt =60A/ μ s; see table 8
Peak reverse recovery current	I _{rrm}	-	30	-	А	V_R =400V, I_F =33A, di_F/dt =60A/ μ s; see table 8

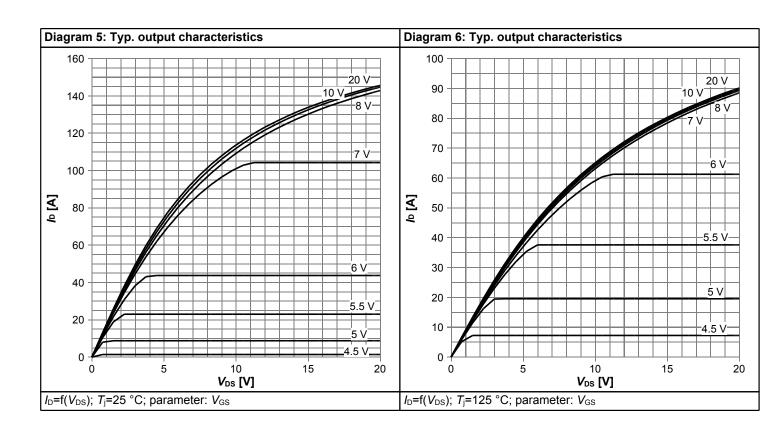


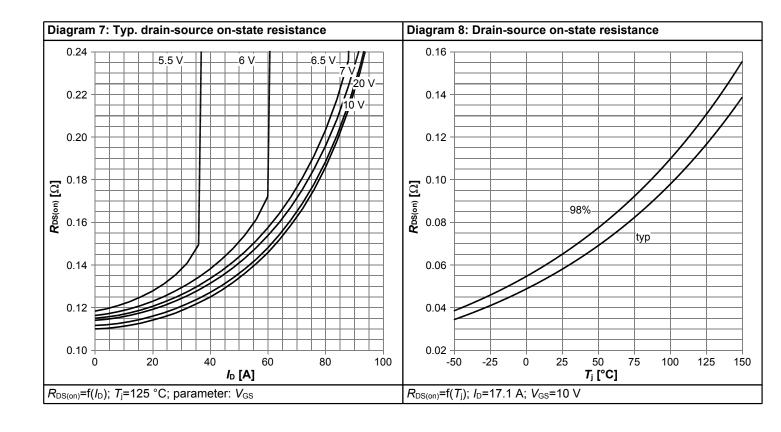
5 Electrical characteristics diagrams



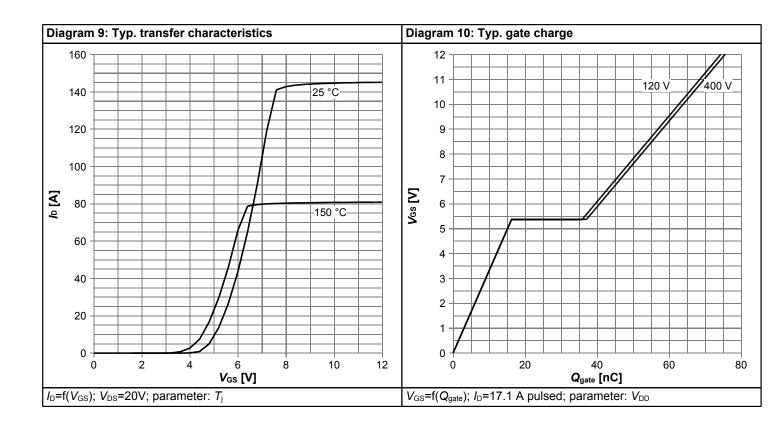


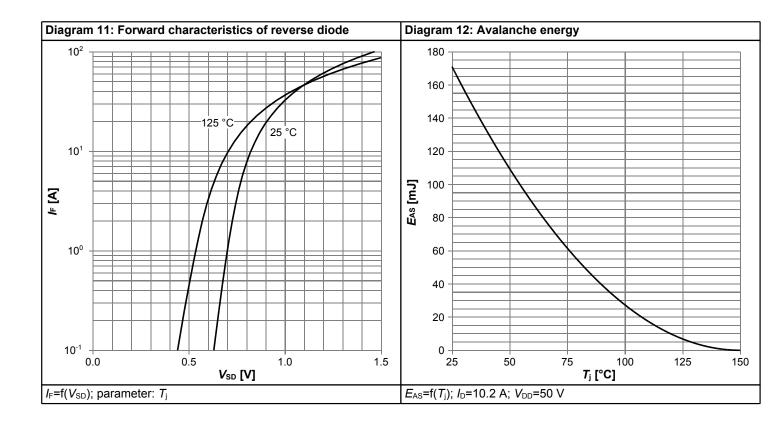




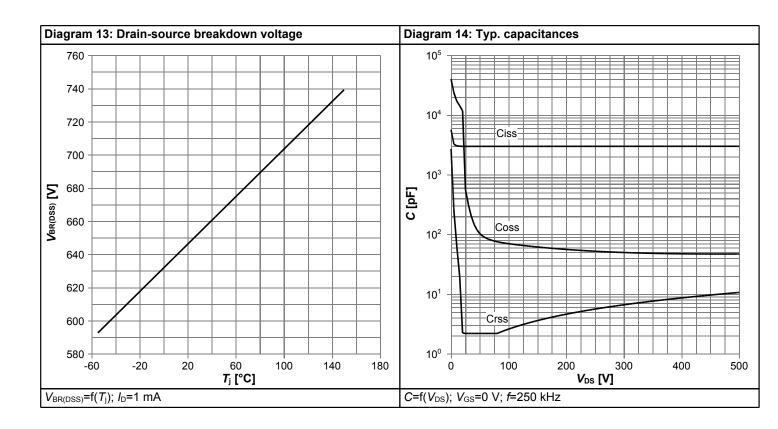


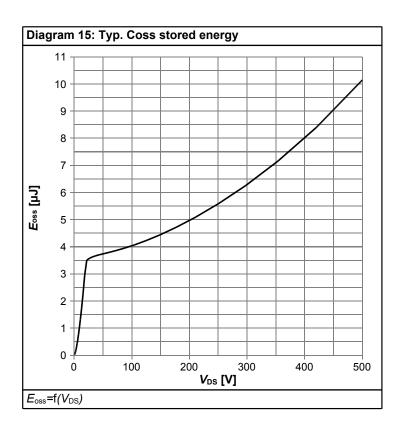














6 Test Circuits

Table 8 Diode characteristics

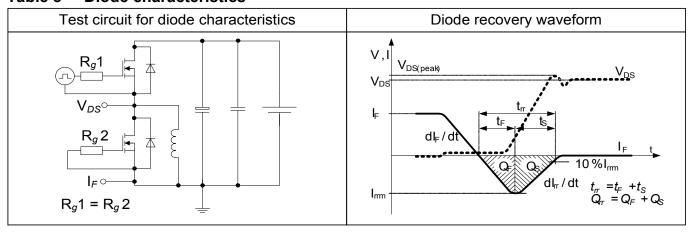


Table 9 Switching times

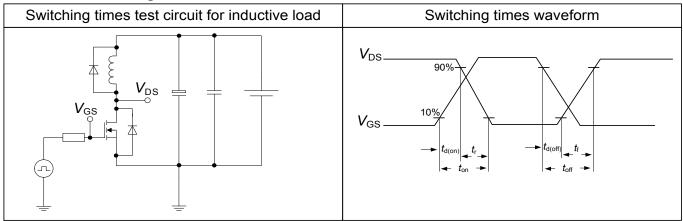
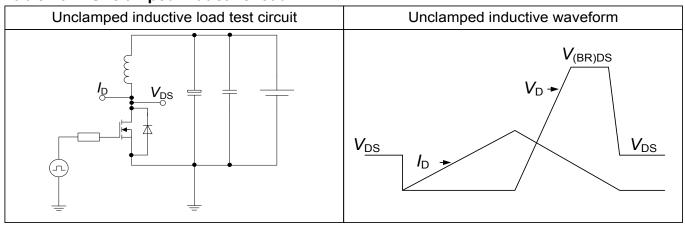


Table 10 Unclamped inductive load





7 Package Outlines

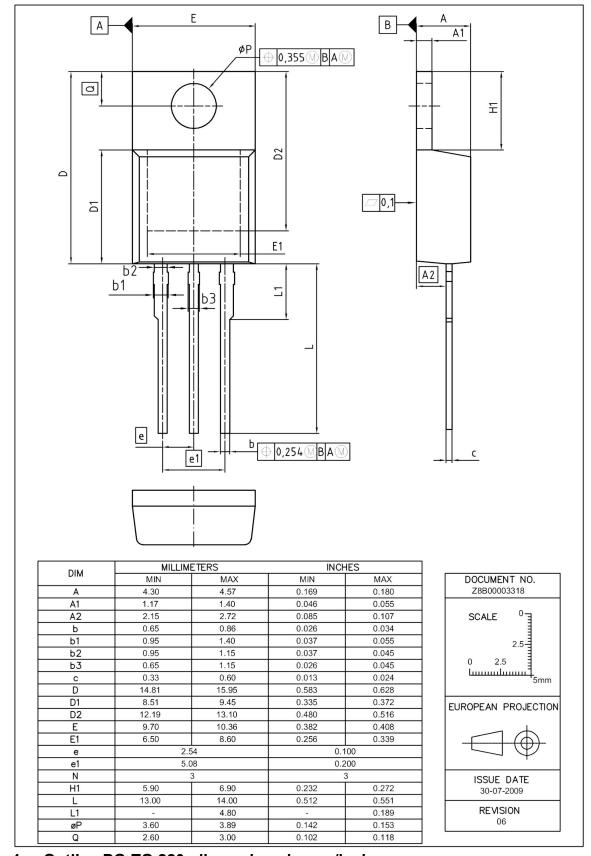


Figure 1 Outline PG-TO 220, dimensions in mm/inches



8 Appendix A

Table 11 Related Links

- IFX CoolMOS[™] C7 Webpage: <u>www.infineon.com</u>
- IFX CoolMOS[™] C7 application note: <u>www.infineon.com</u>
- IFX CoolMOS[™] C7 simulation model: www.infineon.com
- IFX Design tools: www.infineon.com



650V CoolMOS™ C7 Power Transistor

IPP65R065C7

Revision History

IPP65R065C7

Revision: 2013-10-11, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)				
2.0	2013-10-11	Release of final version				

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Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to: erratum@infineon.com

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